## Signetics

### Military Application Specific Products

#### DESCRIPTION

The 82S105 is a bipolar programmable state machine of the Mealy type. It contains logic AND-OR gate arrays with user programmable connections which control the inputs of on-chip State and Output Registers. These consist respectively of 6 Qp, and 8 Qp edge-triggered, clocked S/R flip-flops, with an asynchronous Preset option. All flip-flops are unconditionally preset to "1" during power turn-on.

The AND array combines 16 external inputs, I<sub>0-15</sub>, with six internal inputs, P<sub>0-5</sub>, fed back from the State Register to form up to 48 transition terms (AND terms).

All transition terms can include True, False, or Don't Care states of the controlling variables, and are merged in the OR array to issue next-state and next-output commands to their respective registers on the Low-to-High transition of the Clock pulse. Both True and Complement transition terms can be generated by optional use of the internal variable (C) from the Complement Array. Also, if desired, the

# 82S105 (PLS105)

Field-Programmable Logic Sequencer  $(16 \times 48 \times 8)$ 

Signetics Programmable Logic

**Product Specification** 

Preset input can be converted to Output Enable function, as an additional user-programmable option.

#### **FEATURES**

- Field-programmable (Ni-Cr link)
- 16 input variables
- 8 output functions
- 48 transition terms
- 6-bit State Register
- 8-bit Output Register
- Transition Complement Array
- Positive edge-trigger clock
- Programmable asynchronous preset or Output Enable
- Power-on preset to all "1" of internal registers
- f<sub>MAX</sub> = 10.5MHz
- 650mW power dissipation (typical)
- TTL compatible

- Single +5V supply
- 3-state outputs

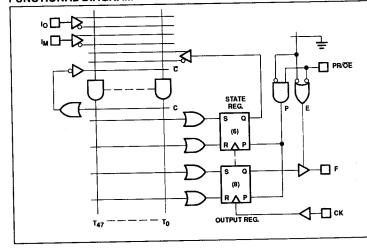
#### **APPLICATIONS**

- Interface protocols
- Sequence detectors
- Peripheral controllers
- Timing generators
- Sequential circuits
- Elevator controllers
- Security locking systems
- Counters
- Shift registers

#### **ORDERING INFORMATION**

DESCRIPTION	ORDER CODE
28-Pin Ceramic DIP 600mil-wide	82S105/BXA
28-Pin CLCC	82S105/B3A
28-Pin Ceramic FlatPack	82S105/BYA

#### **FUNCTIONAL DIAGRAM**



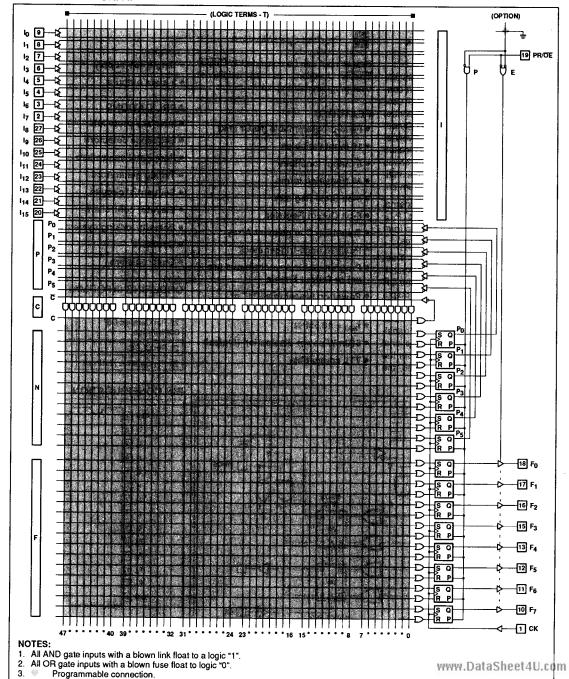
#### PIN CONFIGURATION

111 00111 1001	
	¬
CLK 🔟	O 28 vcc
17 🔼	27 l <sub>8</sub>
I <sub>6</sub> 3	26 lg
is 4	25 l <sub>10</sub>
14 5	24 l <sub>11</sub>
13 6	23 l <sub>12</sub>
12 7	22 l <sub>13</sub>
11 8	21 l <sub>14</sub>
69	20 l <sub>15</sub>
F <sub>7</sub> 10	19 PR/OE
F <sub>6</sub> 11	18 F <sub>0</sub>
F <sub>5</sub> 12	17 F <sub>1</sub>
F <sub>4</sub> 13	16 F <sub>2</sub>
GND 14	15 F <sub>3</sub>
_	
For LLCC pin assign	ments see JEDEC Standard 21

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#### **FPLS LOGIC DIAGRAM**



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#### **PIN DESCRIPTION**

PIN NO.	SYMBOL	NAME AND FUNCTION	POLARITY
1	СК	Clock: The Clock input to the State and Output Registers. A Low-to-High transition on this line is necessary to update the contents of both registers.	Active-High
2 - 8 20 - 27	I <sub>1 - 15</sub>	Logic Inputs: The 15 external inputs to the AND array used to program jump conditions between machine states, as determined by a given logic sequence.	Active-High/Low
9	l <sub>o</sub>	Logic/Diagnostic Input: A 16th external logic input to the AND array, as above, when exercised with standard TTL levels. When I <sub>0</sub> is held at +10V, device outputs F <sub>0.5</sub> reflect the contents of State Register bits P <sub>0.5</sub> . The contents of each Output Register remains unaltered.	Active-High/Low
10 - 13 15 - 18	F <sub>0-7</sub>	<b>Logic/Diagnostic Outputs:</b> Eight device outputs which normally reflect the contents of Output Register bits $Q_{0-7}$ , when enabled. When $I_0$ is held at +10V, $F_{0-5} = (P_{0-5})$ , and $F_{6-7} = \text{Logic "1"}$ .	Active-High
19	PR/OE	Preset or Output Enable Input: A user programmable function:	Active-High (H)
.•		<ul> <li>Preset: Provides an asynchronous preset to logic "1" of all State and Output Register bits. Preset overrides Clock, and when held High, clocking is inhibited and F<sub>0-7</sub> are High. Normal clocking resumes with the first full clock pulse following a High-to-Low clock transition, after Preset goes Low.</li> </ul>	A since have (b)
		Output Enable: Provides an Output Enable function to all output buffers F <sub>0-7</sub> from the Output Register.	Active-Low (L)

#### ABSOLUTE MAXIMUM RATINGS1

SYMBOL	PARAMETER	RAT	UNIT			
STWIDOL		Min	Max	<u> </u>		
V <sub>CC</sub>	Supply voltage		+7	V <sub>DC</sub>		
V <sub>I</sub>	Input voltage		+10.0	V <sub>DC</sub>		
V <sub>O</sub>	Output voltage		+5.5	V <sub>DC</sub>		
l <sub>iK</sub>	Input currents	-30	+30	mA		
lo	Output currents		+100	mA		
TA	Operating temperature range	-55	+125	°C		
T <sub>STG</sub>	Storage temperature range	-65	+150	°C		

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#### DC ELECTRICAL CHARACTERISTICS -55°C $\leq$ T<sub>A</sub> $\leq$ +125°C, 4.5V $\leq$ V<sub>CC</sub> $\leq$ 5.5V

SYMBOL	PARAMETER <sup>3</sup>	TEST CONDITIONS <sup>3</sup>		LIMITS3		UNIT
		·	Min	Typ <sup>2</sup>	Max	
Input Volta	ge			·		
ViH	High	V <sub>CC</sub> = 5.5V	2			٧
V <sub>IL</sub>	Low	V <sub>CC</sub> = 4.5V			0.8	٧
V <sub>IK</sub>	Clamp <sup>4</sup>	V <sub>CC</sub> = Min, I <sub>IK</sub> = -18mA		-0.8	-1.2	V
Output Vol	age					
	_	V <sub>CC</sub> = 4.5V				
V <sub>OH</sub>	High <sup>5</sup>	I <sub>OH</sub> = -2mA	2.4			٧
V <sub>OL</sub>	Low <sup>6</sup>	I <sub>OL</sub> = 9.6mA	ı	0.35	0.5	٧
Input Curre	nt					
		V <sub>CC</sub> = 5.5V				
l <sub>IH</sub>	High	V <sub>I</sub> = 5.5V		<1	50	μА
I <sub>IL</sub>	Low	V <sub>I</sub> = 0.45V		-10	-150	μА
I <sub>IL</sub>	Low (CK input)	V <sub>i</sub> = 0.45 V		-50	-350	μА
Output Cur	rent			•	'	
		V <sub>CC</sub> = 5.5V				
l <sub>O(OFF)</sub>	Hi-Z state <sup>7</sup>	V <sub>O</sub> = 5.5V		1	60	μА
		V <sub>O</sub> = 0.45V		-1	-60	μА
los	Short circuit <sup>4,8</sup>	V <sub>O</sub> = 0V	-15		-85	mA
lcc	V <sub>CC</sub> supply current <sup>9</sup>	V <sub>CC</sub> = 5.5V	i	120	185	mA
Capacitano	e <sup>7,10</sup>				L	
		V <sub>CC</sub> = 5.0V	1			
CIN	Input	V <sub>I</sub> = 2.0V	-	8	13	ρF
C <sub>OUT</sub>	Output	V <sub>O</sub> = 2.0V		10	15	pF

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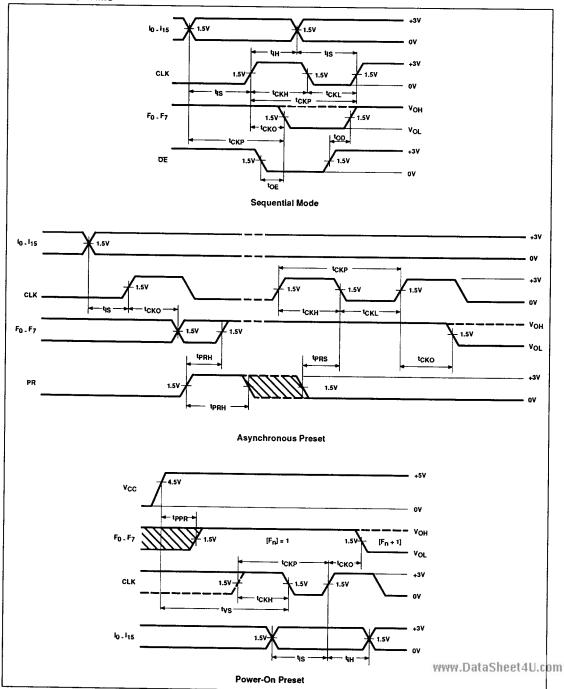
#### AC ELECTRICAL CHARACTERISTICS -55°C ≤ TA ≤ +125°C, 4.5V ≤ VCC ≤ 5.5V

SYMBOL	PARAMETER	ТО	FROM	1		UNIT		
SIMBOL	T ANAMETE:			Min	Typ <sup>11</sup>	Max		
Pulse Widtl	1							
tскн	Clock <sup>12</sup> High	CK-	CK+	40	15		ns	
t <sub>CKL</sub>	Clock Low	CK+	CK-	40	15		ns	
	Period (w/o C-array)	CK+	CK+	95	40		ns	
CKP1	Period (w/C-array) <sup>10</sup>	CK+	CK+	135	60	1	ns	
CKP2	Preset pulse	PR+	PR-	40	15		ns	
Setup Time								
	Input	CK+	Input±	60			ns	
t <sub>IS1</sub>	Input (through Complement array) <sup>13</sup>	CK+	Input±	100	1		ns	
t <sub>IS2</sub>	Power-on preset <sup>13</sup>	CK-	V <sub>cc+</sub>	5	-10	ļ	ns	
t <sub>VS</sub>	Preset <sup>10</sup>	CK-	PŘ-	5	-10		ns	
ters Hold Time	Fieset		<u></u>					
t <sub>lH</sub>	Input <sup>10</sup>	Input±	CK+	10	-10		ns	
Propagation	<u> </u>		····					
	Clock	Output <sub>±</sub>	CK+		15	35	ns	
<sup>t</sup> cko	Output Enable <sup>13</sup>	Output-	OE-	i	20	40	ns	
t <sub>OE</sub>	Output Disable <sup>13</sup>	Output+	OE+		20	40	ns	
t <sub>OD</sub>	Preset	Output+	PR+		18	45	ns	
tpr	Power-on preset <sup>10</sup>	Output+	V <sub>CC</sub> +		0	20	ns	
t <sub>PPR</sub>		3040			1	<u> </u>		
	of Operation			1	T	10.5	MHz	
f <sub>MAX</sub>	w/o C-array				1	8.3	MH	
f <sub>MAX</sub> C	w/C-array <sup>10</sup>		L			1		

#### NOTES:

- 1. Stresses above those listed under "Absolute Maximum Ratings" may cause malfunction or permanent damage to the device. This is a stress rating only. Functional operation at these or any other conditions above those indicated in the operational and programming specification of the device is not implied.
- All typical values are at V<sub>CC</sub> = 5V, T<sub>A</sub> = +25°C.
- 3. All voltage values are with respect to network ground terminal.
- 4. Test one at a time.
- Measured with  $V_{lL}$  applied to  $\overline{\text{OE}}$  and a logic High stored, or with  $V_{lH}$  applied to PR.
- 6. Measured with a programmed logic condition for which the output is at a Low logic level, and V<sub>IL</sub> applied to PR/OE Output sink current is supplied through a resistor to Vcc
- Measured with V<sub>H</sub> applied to PR/OE
- 8. Duration of short circuit should not exceed 1 second.
- 9. I<sub>CC</sub> is measured with the PR/OE input grounded, the outputs open.
- 10. Guaranteed, but not tested.
- 11. All typical values are at V<sub>CC</sub> = 5V, T<sub>A</sub> = +25°C.
- 12. To prevent spurious clocking, clock rise time (10% 90%)  $\leq$  30ns.
- 13. Not testable on unprogrammed devices.

#### TIMING DIAGRAMS



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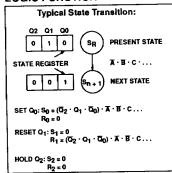
#### **TIMING DEFINITIONS**

SYMBOL	PARAMETER
t <sub>CKH</sub>	Width of input clock pulse.
t <sub>CKL</sub>	Interval between clock pulses.
t <sub>CKP1</sub>	Operating period — when not using Complement Array.
t <sub>IS1</sub>	Required delay between beginning of valid input and positive transition of Clock.
t <sub>CKP2</sub>	Operating period — when using Complement Array.
t <sub>iS2</sub>	Required delay between beginning of valid Input and positive transition of Clock, when using optional Complement Array (two passes necessary through the AND Array).

SYMBOL	PARAMETER
tvs	Required delay between V <sub>CC</sub> (after power-on) and negative transition of Clock preceding first reliable clock pulse.
1PRS	Required delay between negative transition of Asynchronous Preset and negative transition of Clock preceding first reliable clock pulse.
t <sub>iH</sub>	Required delay between positive transition of Clock and end of valid Input data.
тско	Delay between positive transition of Clock and when outputs become valid (with PR/OE Low).

SYMBOL	PARAMETER
t <sub>OE</sub>	Delay between beginning of Output Enable Low and when Outputs become valid.
t <sub>OD</sub>	Delay between beginning of Output Enable High and when Outputs are in the Off-State.
ten	Delay between positive transition of Preset and when Outputs become valid at "1".
tppg	Delay between V <sub>CC</sub> (after power-on) and when Outputs become preset at "1".
tpRH	Width of preset input pulse.
f <sub>MAX</sub>	Maximum clock frequency.

#### **LOGIC FUNCTION**



#### **VIRGIN STATE**

A factory shipped virgin device contains all fusible links intact, such that:

- PR/OE option is set to PR. Thus, all outputs will be at "1", as preset by initial power-up procedure.
- 2. All transition terms are disabled (0).
- 3. All S/R flip-flop inputs are disabled (0).
- The device can be clocked via a Test Array pre-programmed with a standard test pattern.

NOTE: The Test Array pattern must be deleted before incorporating a user program. This is accomplished automatically by any Signetics qualified programming equipment.

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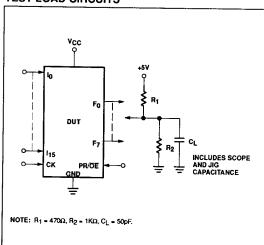
#### TRUTH TABLE

V <sub>CC</sub>	OPT	TION	ON					1
	PR	OE	<b>1</b> 40	СК	S	R	Q <sub>P/F</sub>	F
	Н		*	X	Х	X	н	н
	L		+10V	×	X	X	Q <sub>n</sub>	(Q <sub>P</sub> ) <sub>n</sub>
	L		X	X	X	X	Qn	(Q <sub>F</sub> ) <sub>n</sub>
		H	*	X	Х	Х	Qn	Hi-Z
+5V		L	+10V	X	X	X	Qn	(Q <sub>P</sub> ) <sub>n</sub>
		L	X	X	X	X	Qn	(Q <sub>F</sub> ) <sub>n</sub>
		L	x	1	L	Ĺ	Qn	(Q <sub>F</sub> ) <sub>n</sub>
		L	X	1	L	н	L	ا
		L	x	1	Н	L	н	н
		L	х	1	Н	Н	IND.	IND.
↑	X	X	X	Х	Х	X	Н	1

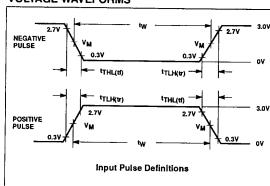
#### NOTES:

- . Positive Logic  $S/R = T_0 + T_1 + T_2 + ... + T_{47}$  $T_n = C(i_0 | I_1 | I_2 ...) (P_0 P_1 ... P_5)$
- 2. Either Preset (Active-High) or Output Enable (active-Low) are available, but not both. The desired function is a user programmable option.
- 3.  $\uparrow$  denotes transition from Low to High level,
- 4. R = S = High is an illegal input condition.
- 5. \* = H/L/+10V,
- X = Don't Care (≤ 5.5V).

#### **TEST LOAD CIRCUITS**



#### **VOLTAGE WAVEFORMS**



INPUT PULSE CHARACTERISTICS												
V <sub>M</sub>	Rep. Rate	Pulse Width	t <sub>TLH</sub>	t <sub>THL</sub>								
1.5V	1 MHz	500ns	≤5ns	≤5ns								

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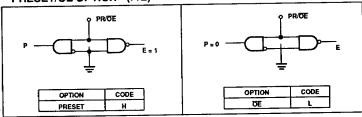
#### LOGIC PROGRAMMING

The FPLS can be programmed by means of Logic programming equipment.

With Logic programming, the AND/OR gate input connections necessary to implement the desired logic function are coded directly from the State Diagram using the Program Table on the following page.

In this table, the logic state or action of control variables C, I, P, N and F, associated with each Transition Term Tn is assigned a symbol which results in the proper fusing pattern of corresponding link pairs, defined as follows:

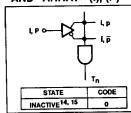
#### PRESET/OE OPTION - (P/E)

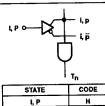


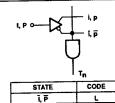
#### PROGRAMMING THE 82S105:

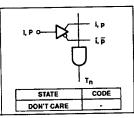
The 82S105 has a power-up preset feature. This feature insures that the device will power-up in a known state with all register elements (State and Output Register) at logic High (H). When programming the device it is important to realize this is the initial state of the device. You must provide a next state jump if you do not wish to use all Highs (H) as the present state.

#### "AND" ARRAY - (I), (P)

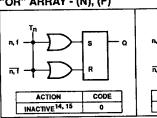


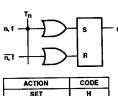


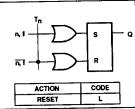


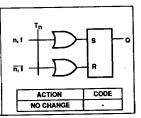


#### "OR" ARRAY - (N), (F)

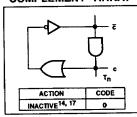


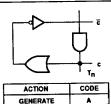


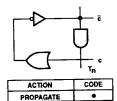


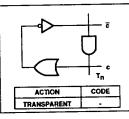


#### "COMPLEMENT" ARRAY - (C)









- 14. This is the initial unprogrammed state of all link pairs. It is normally associated with all unused (inactive) AND gates T<sub>n</sub>.
- 15. Any gate Tn will be unconditionally inhibited if any one of its I or P link pairs are left intact.
- 16. To prevent simultaneous Set and Reset flip-flop commands, this state is not allowed for N and F link pairs coupled to active gates Tn (see flip-flop truth tables).
- 17. To prevent oscillations, this state is not allowed for C link pairs coupled to active gates T<sub>n</sub>.

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May 13, 1987

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#### **FPLS PROGRAM TABLE**

													PF	ROGRAM TA	ABLE E	NT	RII	ES																					
	CL	JS	ТО	ME	RI	NAI	ME																		AND				Ţ	_				OR		_	_	_	
	PL	IRO	CH	AS	E	ORI	DEI	R#											_			ļ	Г	INACTIVE	, 0	٦			I	٦	IN/	сп	VE		Ţ.	0	Ŧ		
l	SI	GN	ΕT	C	3 0	Eν	ICI	E#				С	F(	XX)	(X)							- 1		GENERATE	. A			_	i			T			•	Н	٦	••-	, Fr
	Cι	JS	Ю	ME	RS	SYN	MB	OLI	ZE	D P	AR	T #	<b>#</b>									- 1	L	PROPAGATE			•	'n	i		RE	SET			Ė	L	$\Box$	NS	, FF
	TO	TA	L	NU	ME	BEF	10	FP	AR	TS													L	TRANSPAREN	<u> </u>	╛			1	L	NO	CH	ANC	3E		_	╛		
	PR	00	GR	AΝ	l T	ABI	LE_																Ę	INACTIVE	0				Ļ			_	_;				_	_	
	RE																					I,P H											_	_					
	DA	TE	=																			- 1	-	Î, P	, r	4	m		1						÷		4	P/	E
<u> </u>	_		_																			$\perp$	L	DON'T CARE					i	L		_			÷	L	┙		
								-			Al	ND														F		_		_	Of		N (F	P/E)			_	_	
TEDM									INP	UT (	lm)							TP	RES	ENT	STA	TE (	(P_)	REMAR	KS		NEX	TST	ATF	/Ne	.,	ΤÌ		_	HITP	UT (	(Er)		
TERM	Un.	15	14	Πī	<u>3   1</u>	2[1	ijī	0	j [	B   7	7] (	1	5	4] 3	1 2	T <sub>1</sub>	1 c	ة ا	T 4	13	7 <u>2</u>	Γí	10					3				ŀ"·	1 =						170
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2		E	t	1	$\pm$		$\pm$	$\pm$	+	-	+	+	+	•	+	+	╁	╁	+	+	╁	+	+	<del> </del>		┝	⊢	H	_	-	┝	⊢	₩	╀	┼-	:	₽	4	Ŧ
3	H	H	+	+	+	Ť	F	Ŧ	Ŧ		Ŧ	Ŧ	7		Ŧ	Ŧ	Ţ.	T	T	#		١	$\vdash$									t	$\vdash$	$\vdash$	İ	-	T	士	$\pm$
5			$^{\pm}$	t	$\pm$	_	$\pm$	士	$\pm$		$\pm$	╁	$\pm$	+	+	+	+-	╀	+	╀	╁	╁╌	$\vdash$	ļ		$\vdash$	$\vdash$	$\vdash$	_	H	F	F		-	F	_	F	Ŧ	F
6 7	F	F	F	F	F	÷	Ŧ	Ŧ	Ŧ	÷	Ŧ	T	Ŧ	-	Ţ	T	T	T	T	I	L					П	Ė							L	İ	-	T	士	$\pm$
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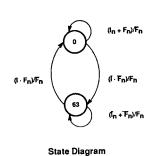
82S105

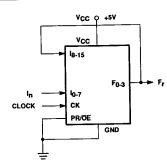
#### **TEST ARRAY**

The FPLS may be subjected to AC and DC parametric tests prior to programming via an on-chip test array.

The array consists of test transition terms 48 and 49, factory programmed as shown below.

Testing is accomplished by clocking the FPLS and applying the proper input sequence to  $1_{0.7}$  as shown in the test circuit timing diagram.





**FPLS Under Test** 

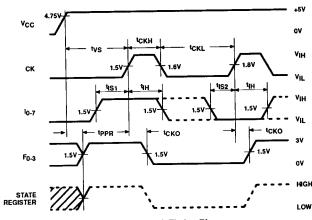
#### **TEST ARRAY PROGRAM**

- T											Al	ND.											
É R	С			1	131		г т	1			INPL	JT (li	n)					PF	ESE	NT S	STAT	E (P	's)
M	ັ	5	4	3	2	1	o	9	8	7	6	5	4	3	2	1	0	5	4	3	2	1	0
48	A	н	Η	Н	H	Ι	Ξ	Н	H	Ξ	Ξ	Н	Н	Н	Н	Н	Ħ	Н	Н	1	쁘	н	Щ
49	•	L	L	L.	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	ᄔ	L	ᄔ

	OPTION (P/E)												н		
	OR														
	NEX	TST	ATE	(Ns)			OUTPUT (Fr)								
5	4	3	2	[i	Γ <b>•</b>	7	6	5	4	3	2	1	0		
L	L	ī	ī	T	L	L	L	L	L	۲	۲	۲	L		
H	н	Н	Н	Н	н	н	н	Н	н	H	Н	н	Н		

#### **Test Array Program**

Both terms 48 and 49 must be deleted during user programming to avoid interfering with the desired logic function. This is accomplished automatically by any Signetic's qualified programming equipment.



**Test Circuit Timing Diagram** 

#### **TEST ARRAY DELETED**

-		AND																					
E R	С	<u> </u>								INPUT (Im)							PRESENT STATE (Ps)						
М	ľ	5	4	3	2	1	0	9	ГВ	7	6	5	4	3	2	1	0	5	4	3	2	[1	0
48	-	н	Н	Н	Н	Н	н	н	Н	Н	н	Ξ	Ŧ	H	Η	Η	H	Η	Ξ	Τ	H	Н	H
49	•	L	L	L	L	L	L	L	L	L	L	L	Ĺ	L	L	L	L	L	L	L	L	L.	L

_	OPTION (P/E)													Н	ı
OR														١	
NEXT STATE (Na)							OUTPUT (Fr)								
	5	4	3	2	7	6	7	6	5	4	3	2	[1	0	١
	_	-	╒	-	-	-		-	-	-	-	-	_	-	1
	_	_	-	-	-	-	IAI	ηHη	(£)	at	aS	he	et	ИН.	1

**Test Array Deleted** 

### Packaging Information

#### Military Products

### SIGNETICS STANDARD PACKAGE DESCRIPTIONS

All Military package case outlines and physical dimensions conform with the current revision MIL-M-38510, Appendix C, except for package types which are not included in that specification.

The physical dimensions for standard package types which are not included in Appendix C are included herein in Appendix C format. Case outline letters are assigned to these packages according to JEDEC Publication 101 as follows:

- U: Leadless chip carriers
  - X: Dual-in-line packages
- Y: Flat packages
- 7: All other configurations

A case outline suffix number is assigned herein for identification purposes only, and is not marked on the product.

Signetics Military products are offered in a wide range of package configurations to optimally fit our customer needs.

- Dual-in-line Packages; Frit glass sealed CERDIP (F package family) with 8-40 leads, and side-brazed ceramic (I package family) with 48-54 leads.
- Flat Packages; Frit glass sealed alumina CERPAC (W package family) with 14-28 leads, and brazed leaded ceramic (Q package family) with 52 leads.

- Ceramic Chip Carriers; triple laminated, metal-lidded LCC (G package family) with 20-68 terminals.
- Pin Grid Array; metal-lidded ceramic pin grid (P package family) with 68-100 leads.
- Shown in Table 1 are the case outline letters assigned according to Appendix C of MIL-M-38510 and JEDEC publication 101. Unless otherwise noted, all package types are Configuration 1 and all lead finishes are hot solder dip Finish \*A\*.

#### Table 1.

Package Description	Type Designation	Case Outline	Theta-JC °C/Watt4
	D-4	Р	28
8DIP3	D-1	Ċ	28
14DIP3		Ě	28 28
16DIP3	D-2	V	28 .
18DIP3	D-6		28
20DIP3	D-8	R W	28
22DIP4	D-7	W	20
24DIP3	D-9	L	28
24DIP4	D-11	X <sup>2</sup>	28
24DIP6	D-3		28
	D-10	X2	28
28DIP6	D-10	X <sup>2</sup> Q X <sup>2</sup> X <sup>2</sup>	28
40DIP6	D-14 <sup>1</sup>	. <u>7</u> 2	28 28
48DIP6	U-14:	<b>℃</b>	1 28
50DIP9	D-12 <sup>1</sup>	∫ <b>∴</b>	28
64DIP9	D-13 <sup>1</sup>	χ-	
14FLAT	F-2	D	22
16FLAT	F-5	F	22
18FLAT	F-10	Y <sup>2</sup>	22
	F-9	92 S K Y2 Y2	22
20FLAT	F-6	l ĸ	22
24FLAT		V2	22
28FLAT	F-11	\ <u>\</u> 2	22
52FLAT	Y-11		
18LLCC	C-9	U <sup>2</sup>	20
20LLCC	C-23	2	20
28LLCC	C-43	3	20
32LLCC	C-12	Ü2 U2 U2	20
44LLCC	Č.5	U <sup>2</sup>	20
	C-5 C-7	l Ü2 -	20
68LLCC	<u> </u>		<del>                                     </del>
68PGA	P-AB	Z <sup>2</sup> Z <sup>2</sup>	20
84PGA	P-AB	! Z <sup>2</sup>	20

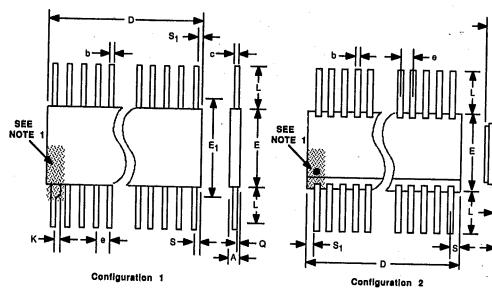
#### NOTES:

- 1. Configuration 2.
- 2. Per JEDEC publication 101.
- 3. Dimension A (LLCC thickness) is 75mils maximum.

See RADC test report RADC-TR-86-97 for thermal resistance confidence and derating.

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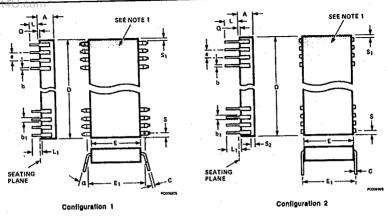


#### NOTES:

- A lead tab (enlargement) or index dot is located within the shaded area shown at Pin 1. Other pin numbers proceed sequentially from Pin 1 counterclockwise (as viewed from the top of the device).
- This dimension allows for off-center lid, meniscus, and glass overrun.
- The reference pin spacing is 0.050 between centerlines. Each pin centerline is located within ± 0.005 of its logitudinal position relative to the first and last pin numbers.
- This dimension is measured at the point of exit of the lead body.
- 5. This dimension applied to all four corner pins.
- Lead dimensions include 0.003 inch allowance for hot solder dip lead finish.

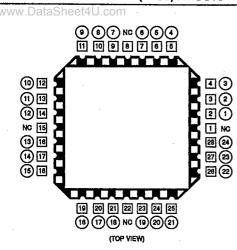
OUTLINE		T						
CONFIGURATION		1						
NO. LEADS		52						
SIG. PKG.	(	NOTES						
SYMBOL	INC							
STMBUL	Min	Max						
A	0.045	0.100						
b	0.015	0.026	6					
c	0.008	0.015	6					
D		1.330	2					
E	0.620	0.660						
e	0.05	0.050 BSC						
L.	0.250	0.370	- 1					
Q	0.054	0.0666	4					
S	-	0.045	5					
<b>S</b> 1	0.005		5					
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### CASE OUTLINES X (DUAL IN-LINE PACKAGES)

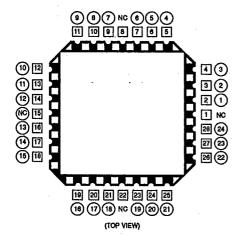


- 1. An index notch is located within the shaded area shown. Pin 1 is adjacent to the notch to the immediate left (as viewed from the top of the device) and other pin numbers proceed sequentially from Pin 1 counterclockwise.
- 2. The minimum limit for Dimension b1 is 0.023 inches for all four corner pins.
- 3. This dimension allows for off-center lid, meniscus, and glass overrun.
- 4. This dimension is measured at the centerline of the leads for Configuration 2.
- 5. The reference pin spacing is 0.100 between centerlines. Each pin centerline is located within ±0.010 of its longitudinal position relative to the first and last pin numbers.
- 6. This dimension is measured from the seating plane to the base plane.
- 7. This dimension applies to all four corner pins.
- 8. Lead dimensions include 0.003 inch allowance for hot solder dip lead finish.

#### LEADLESS CHIP CARRIER (LLCC) PINOUTS



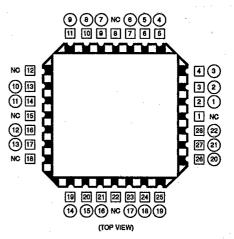
24-Lead Logic Pinout for 28 Terminal Chip Carrier



24-Lead Memory Pinout for 28 Terminal Chip Carrier

☐ = Chip Carrier Terminal Number
☐ = Dual In-Line Lead Number
NC = No Connect

28-Lead Pinout for 28 Terminal Chip Carrier for all Device Types



22-Lead Memory Pinout for 28 Terminal Chip Carrier

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